Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,928	BUSHNELL ET AL.	
Examiner	Art Unit	
Huy Q. Phan	2687	

SEARCHED							
Class	Subclass	Date	Examiner				
455	222	11/28/05	48				
	554.1						
	514						
	426.1						
	426.2						
•	417						
	41.2	4	7				
	414.2	11/28/05	He				

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST SE	ARCH	11/28/05	H	
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